

Search Notes

Application/Control No.

10/813,063

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2182

SEARCHED

Class	Subclass	Date	Examiner
710	2	7/17/2006	ASC
	5		
	8		
	11		
	36		
	59		
	62		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(EAST) USPAT; USPGPUB; EPO; JPO; IBM_TDB; DERWENT Inventor Search	7/17/2006	ASC